

Notice of References Cited

Application/Control No.

10/577,475

Applicant(s)/Patent Under
Reexamination
ODAWARA ET AL.

Examiner

TRAN Q. TRAN

Art Unit

2811

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0178631	09-2003	Udagawa, Takashi	257/99
*	B	US-6,259,122	07-2001	Ota et al.	257/101
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NON-PATENT DOCUMENTS

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